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	Application No.	Applicant(s)
	10/050,171	WATANABE, KENICHI
Notice of Allowability	Examiner	Art Unit
	Matthew E. Warren	2815
The MAILING DATE of this communication appearance All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIOF the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this or other appropriate communicat IGHTS. This application is subject	application. If not included ion will be mailed in due course. THIS
1. $\boxtimes$ This communication is,responsive to <u>the After Final Amend</u>	dment filed on February 1, 2007.	
2. $\boxtimes$ The allowed claim(s) is/are 8-11,13,16 and 20-23.		
3. ☑ Acknowledgment is made of a claim for foreign priority un a) ☑ All b) ☐ Some* c) ☐ None of the:		
<ul> <li>1. ☑ Certified copies of the priority documents have been received.</li> <li>2. ☐ Certified copies of the priority documents have been received in Application No</li> </ul>		
3. Copies of the certified copies of the priority documents have been received in this national stage application from the		
International Bureau (PCT Rule 17.2(a)).  * Certified copies not received:		
•		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application.  THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		
4. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give	nitted. Note the attached EXAMIN es reason(s) why the oath or decl	ER'S AMENDMENT or NOTICE OF aration is deficient.
5. CORRECTED DRAWINGS ( as "replacement sheets") must be submitted.		
(a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review ( PTO-948) attached		
1)  hereto or 2)  to Paper No./Mail Date		
(b) including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date		
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t	l.84(c)) should be written on the dra the header according to 37 CFR 1.1	awings in the front (not the back) of 21(d).
<ol> <li>DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.</li> </ol>		
Attachment(s)  1. Notice of References Cited (PTO-892)	5. Notice of Information	al Patent Application
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. 🔲 Interview Summ	ary (PTO-413),
3. Information Disclosure Statements (PTO/SB/08),	Paper No./Mail 7. ⊠ Examiner's Ame	Date ndment/Comment
Paper No./Mail Date 4.	8. 🖾 Examiner's State	ement of Reasons for Allowance
of Biological Material		
	9.	
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## **DETAILED ACTION**

This Office Action is in response to the After Final Amendment filed on February

1, 2007

## **EXAMINER'S AMENDMENT**

An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

The application has been amended as follows:

This application is in condition for allowance except for the presence of claims 1-6 directed to an invention non-elected without traverse. Accordingly, claims 1-6 have been cancelled.

## Allowable Subject Matter

Claims 8-11, 13, 15, and 20-23 are allowed.

The following is an examiner's statement of reasons for allowance:

In re claims 9 and 23, the prior art references, alone or in combination, do not show a semiconductor device comprising a recess having a pad part and a wiring part, a plurality of insulating regions disposed in the bottom of the pad part, wherein the insulating regions are disposed regularly in the second frame area along a first direction

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at a first period P, and a width of the first frame area long the first direction is equal to or wider than said first period P. None of the cited references mention the relationship between the period and the width of the first frame area. As stated in the applicant's specification (pg. 11), width of the first frame area is set wider than the pitch (period) P to avoid excessive current concentration.

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In re claims 21 and 22, the prior art references, alone or in combination, do not show a semiconductor device comprising a recess having a pad part and a wiring part, a plurality of insulating regions disposed in the bottom of the pad part, and the recess being formed so that the insulating regions are not disposed in a near wiring area superposed upon an extended area of the wiring part into the pad part, within a first frame area having as an outer periphery of the pad part and having a first width but disposed in a second frame area having as an outer periphery an inner periphery of the first frame area and having a second width, wherein the wiring width W1 is in a range from 5 to 10 microns, L1/W1 is 35% (or 30%) or higher, wherein W1 corresponds to the width of the wiring part, while L1 corresponds to the width of the first width. None of the cited references mention the relationship between the wiring width and the first width of the near wiring area. As stated in the applicant's specification (pg. 11), the relationship between L1 and W1 is set in this manner to avoid excessive current concentration.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably

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accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

## Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Matthew E. Warren whose telephone number is (571) 272-1737. The examiner can normally be reached on Mon-Thur and alternating Fri 9:00-5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Kenneth Parker can be reached on (571) 272-2298. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

MEW

February 27, 2007

KENNETH PARKER
SUPERVISORY PATENT EXAMINER